

Restr.

10/756715

Examiner: HUR, JOHN

GAU: 2824

Classification: 365/201.000


Inventor: JEUNG, SEONG-HO, et al

Status: 30 - DOCKETED NEW CASE - READY FOR EXAMINATION

Title: SEMICONDUCTOR DEVICE AND TEST METHOD OF TESTING THE SAME

Bib Data report

Application Title: SEMICONDUCTOR DEVICE AND TEST METHOD OF TESTING THE SAME

Application Num:  (in phx) 10/756715 **Filing Date:**
01/13/2004 **Effective Filing:** 01/13/2004
(Location History) **Foreign/Continuity Data)**

Status: 30/DOCKETED NEW CASE - READY FOR EXAMINATION **Status Date: 05/01/2004**

Patent Number: Not Issued **Issue Date: N/A** **Date of Abandonment: N/A**

Confirmation Number: 2917 **PALM Location:**

Examiner: 79441 **HUR, JOHN (Assignment Data)**
Group Art Unit: 2824 **Class/Subclass: 365/201.000**

State or Country: KOREA, REPUBLIC OF
Sheets/Drawing: 6 **Total Claims: 26** **Independent Claims: 4**

▼ **Inventors:**

Last name, First name:

City:

Country or State:

JEUNG,
SEONG-HO

SUWON-CITY

KOREA,
REPUBLIC OF

10/756715

Examiner: HUR, JOHN

GAU: 2824

Classification: 365/201.000

Inventor: JEUNG, SEONG-HO, et al

Status: 30 - DOCKETED NEW CASE - READY FOR EXAMINATION

Title: SEMICONDUCTOR DEVICE AND TEST METHOD OF TESTING THE SAME

Bib Data report

**JUNG,
JONG-HOON**

**YONGIN-CITY KOREA,
REPUBLIC OF**

**Attorneys: ALL Attorney Docket No: 8021-196
(SS-19274-US)**

**Interference No: Lost Case: No Unmatched Petition:
No L&R Code: 1**